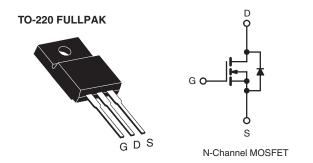


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	3.0		
Q _g (Max.) (nC)	24			
Q _{gs} (nC)	3.3			
Q _{gd} (nC)	13			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s, f = 60 Hz)



- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI820GPbF	
Leau (FD)-nee	SiHFI820G-E3	
SnPb	IRFI820G	
SIFD	SiHFI820G	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	500	V	
Gate-Source Voltage	V_{GS}	± 20			
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}C$	I _D	2.1	А	
	V_{GS} at 10 V_{CS} $T_{C} = 100 ^{\circ}C$		1.3		
Pulsed Drain Current ^a	I _{DM}	8.4			
Linear Derating Factor			0.24	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	110	mJ		
Repetitive Avalanche Currenta	I _{AR}	2.1	Α		
Repetitive Avalanche Energy ^a	E _{AR}	3.0	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	30	W	
Peak Diode Recovery dV/dt ^c	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF MIS SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 44 mH, R_G = 25 Ω , I_{AS} = 2.1 A (see fig. 12).
- c. $I_{SD} \leq$ 2.1 A, $dI/dt \leq$ 50 A/ μ s, $V_{DD} \leq$ V_{DS} , $T_{J} \leq$ 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI820G, SiHFI820G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						•	,
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	V _{GS} = ± 20 V		-	± 100	nA
		V _{DS} = 5	V _{DS} = 500 V, V _{GS} = 0 V		-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V, \	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.3 A ^b	-	-	3.0	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 1.3 A ^b		1.5	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	360	-	- pF
Output Capacitance	C _{oss}	V _I	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		92	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	37	-	
Drain to Sink Capacitance	С	f =	f = 1.0 MHz		12	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V}$ $I_D = 2.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	24	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	3.3	
Gate-Drain Charge	Q _{qd}	1		-	-	13	
Turn-On Delay Time	t _{d(on)}				8.0	-	ns
Rise Time	t _r	$V_{DD} = 250 \text{ V}, \text{ I}_D = 2.1 \text{ A},$ $R_G = 18 \ \Omega, R_D = 120 \ \Omega, \text{ see fig. } 10^b$		-	8.6	-	
Turn-Off Delay Time	t _{d(off)}			-	33	-	
Fall Time	t _f			-	16	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.1	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 2.1 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 2.1 A, dl/dt = 100 A/μs ^b		-	260	520	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.70	1.4	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	on is dor	s dominated by L _S and L _D)			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

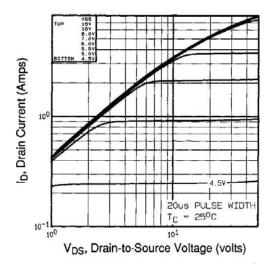


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

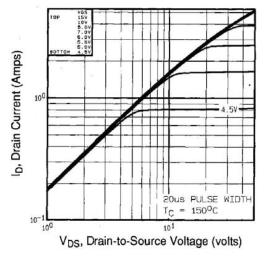


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

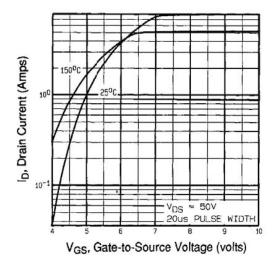


Fig. 3 - Typical Transfer Characteristics

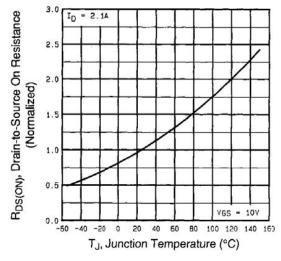


Fig. 4 - Normalized On-Resistance vs. Temperature

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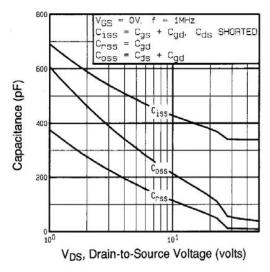


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

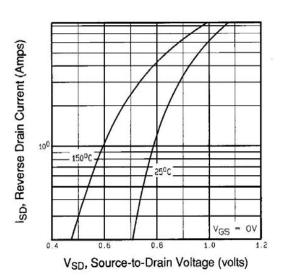


Fig. 7 - Typical Source-Drain Diode Forward Voltage

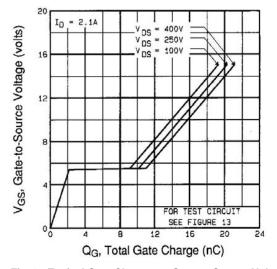


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

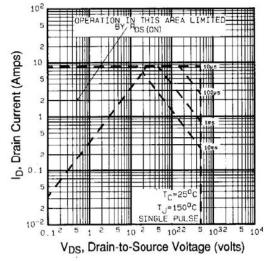
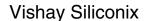


Fig. 8 - Maximum Safe Operating Area





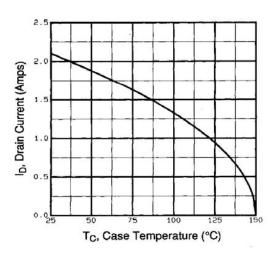


Fig. 9 - Maximum Drain Current vs. Case Temperature

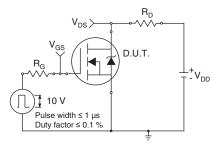


Fig. 10a - Switching Time Test Circuit

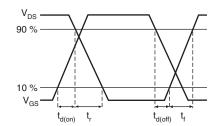


Fig. 10b - Switching Time Waveforms

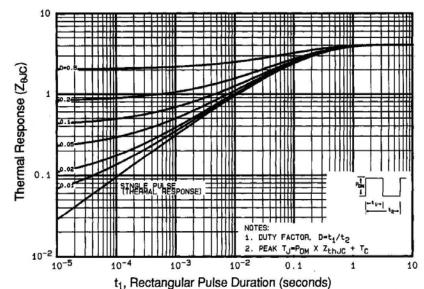


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

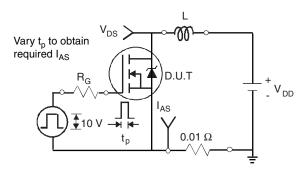


Fig. 12a - Unclamped Inductive Test Circuit

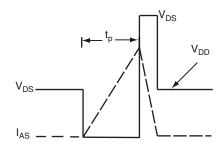


Fig. 12b - Unclamped Inductive Waveforms

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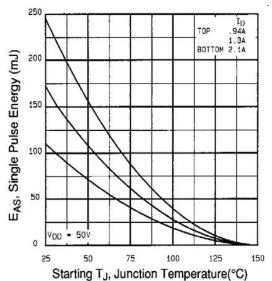


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

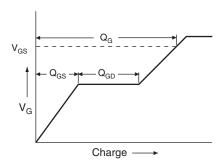


Fig. 13a - Basic Gate Charge Waveform

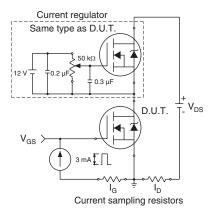
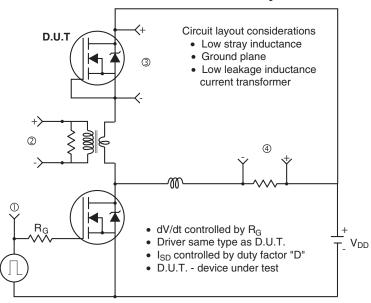
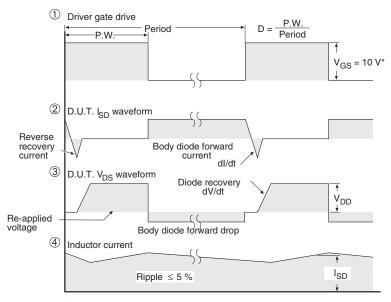


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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